

- ★ Super Low Gate Charge
- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Excellent CdV/dt effect decline
- ★ Advanced trench gate super junction technology

650V Super Junction Power MOSFET

Product Summary



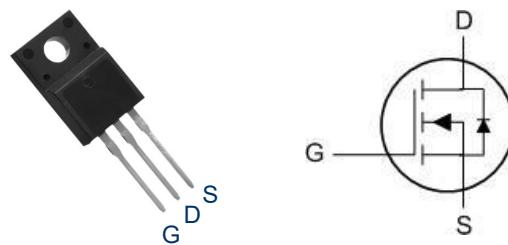
BVDSS	RDS(ON)	ID
650V	160 mΩ	21A

Description

The XR65R180FT use super junction technology and design to provide excellent RDS(ON) with low gate charge. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

The XR65R180FT meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

TO220F Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	± 30	V
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ^{1,6}	21	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ ^{1,6}	13	A
I_{DM}	Pulsed Drain Current ²	62	A
EAS	Single Pulse Avalanche Energy ³	220	mJ
I_{AS}	Avalanche Current	---	A
$P_D @ T_C = 25^\circ C$	Total Power Dissipation ⁴	245	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	---	68	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	---	0.51	°C/W

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Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	650	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	---	---	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=10\text{V}$, $I_D=16\text{A}$	---	160	200	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=16\text{A}$	---	---	---	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	3.2	---	4.6	V
$\Delta V_{\text{GS}(\text{th})}$	$V_{\text{GS}(\text{th})}$ Temperature Coefficient		---	---	---	$\text{mV}/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	5	uA
		$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=100^\circ\text{C}$	---	1000	---	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 30\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=20\text{V}$, $I_D=10\text{A}$	---	14.5	---	S
R_g	Gate Resistance	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	1.5	---	Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=520\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=10\text{A}$	---	41	---	nC
Q_{gs}	Gate-Source Charge		---	12	---	
Q_{gd}	Gate-Drain Charge		---	20	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{GS}}=10\text{V}$, $V_{\text{DS}}=325\text{V}$, $R_G=10\Omega$, $I_D=20\text{A}$	---	43	---	ns
T_r	Rise Time		---	58	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	105	---	
T_f	Fall Time		---	36	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=100\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	1459	---	pF
C_{oss}	Output Capacitance		---	62	---	
C_{rss}	Reverse Transfer Capacitance		---	2	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ^{1,4}	$V_G=V_D=0\text{V}$, Force Current	---	---	21	A
V_{SD}	Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}$, $I_s=16\text{A}$, $T_J=25^\circ\text{C}$	---	---	1.1	V
t_{rr}	Reverse Recovery Time	$I_F=10\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$, $T_J=25^\circ\text{C}$	---	108	---	nS
			---	0.54	---	nC

Note :

F The data is tested by a surface mounted on a 1 inch² FR-4 board with 2 oz copper.

G The data is tested by a pulsed pulse width > 300us, duty cycle < 2%.

H The EAS data shows Max. rating . The test condition is VR_{AMG} > 0, VDD=200V, VGS=10V, L=50mH

I The power dissipation is limited by 50°C junction temperature.

J The data is theoretically the same as A_{D} and A_{DM} . In real applications, it should be limited by total power dissipation.

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Typical Performance Characteristics

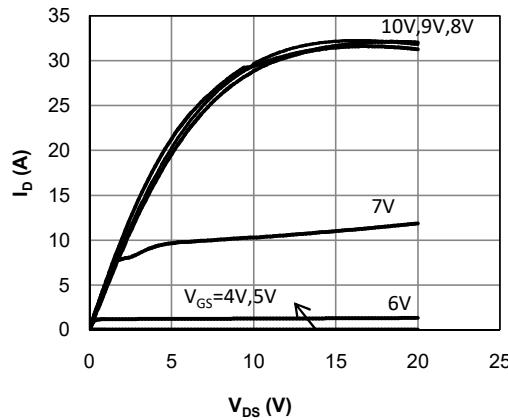
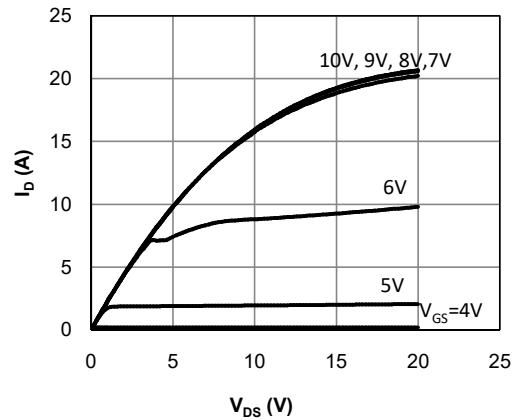
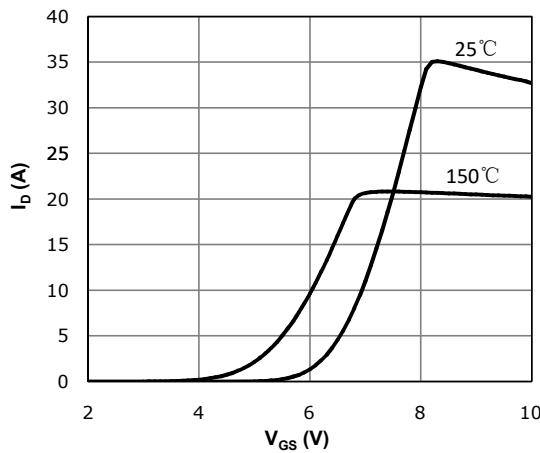
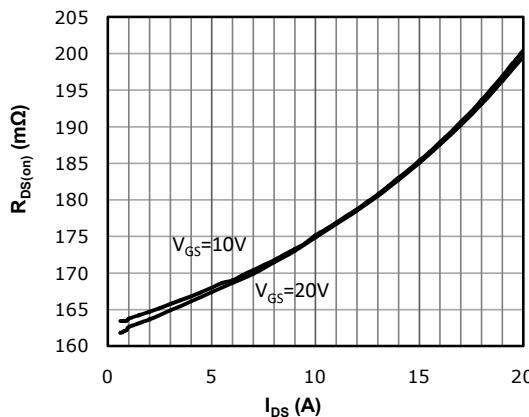
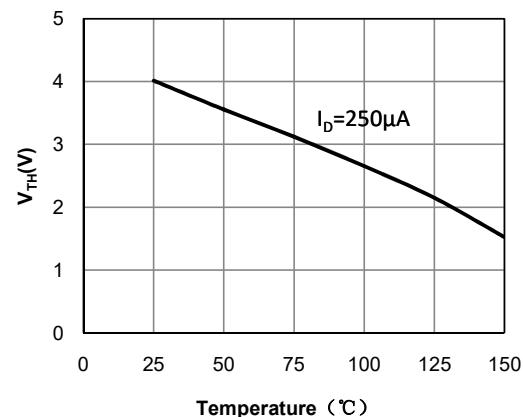
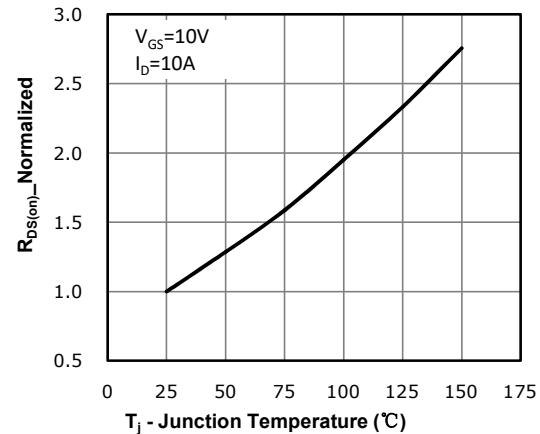
Fig 1. Output Characteristics ($T_j=25^\circ\text{C}$)Fig 2. Output Characteristics ($T_j=150^\circ\text{C}$)

Fig 3: Transfer Characteristics

Fig 5: $R_{DS(on)}$ vs. I_{DS} Characteristics ($T_j=25^\circ\text{C}$)Fig 4: V_{TH} vs. T_j Temperature CharacteristicsFig 6: $R_{DS(on)}$ vs. Temperature

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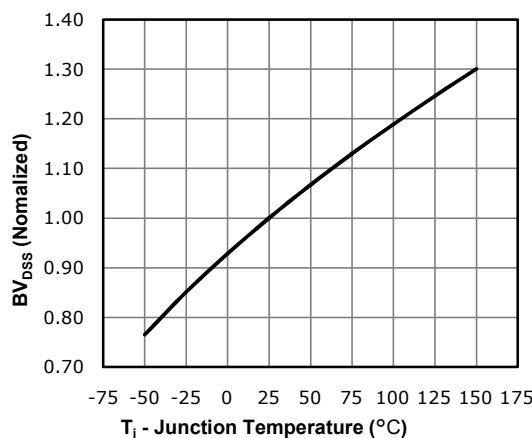
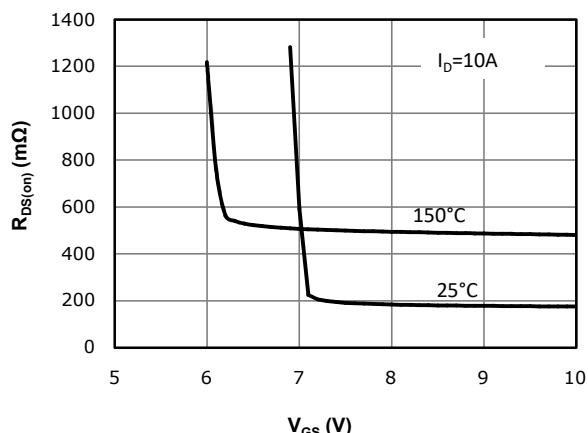
Fig 7: BV_{DSS} vs. TemperatureFig 8: $R_{DS(on)}$ vs. Gate Voltage

Fig 9: Body-diode Forward Characteristics

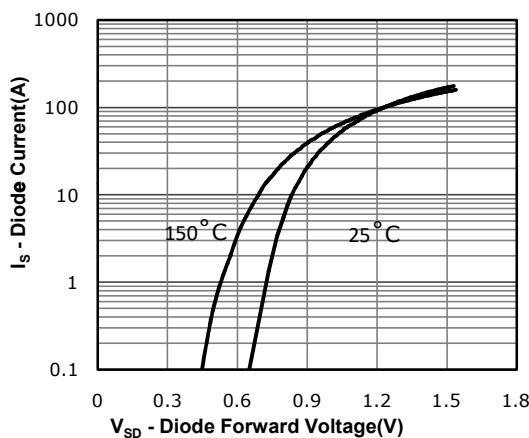


Fig 10: Gate Charge Characteristics

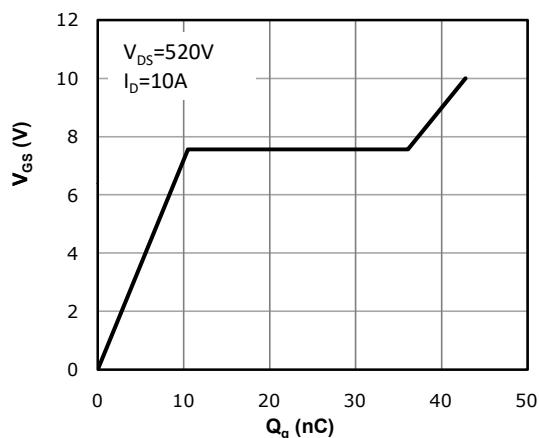


Fig 11: Capacitance Characteristics

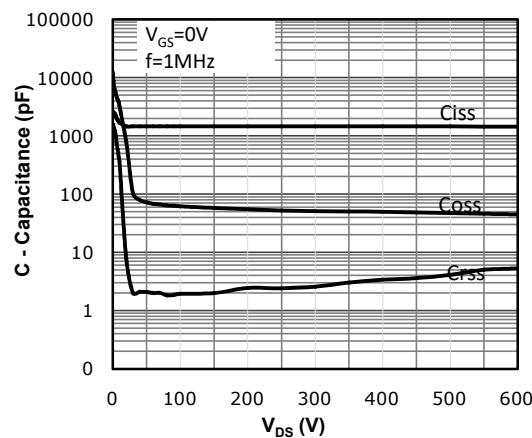
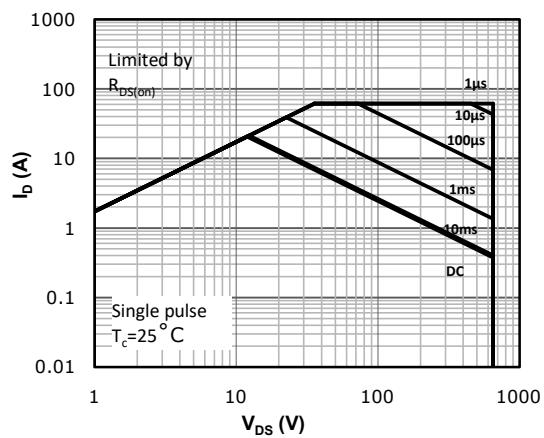
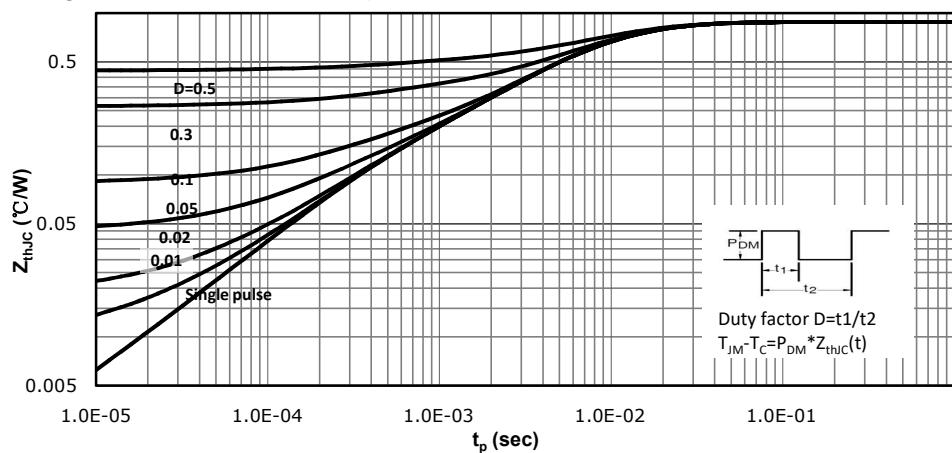


Fig 12: Safe Operating Area



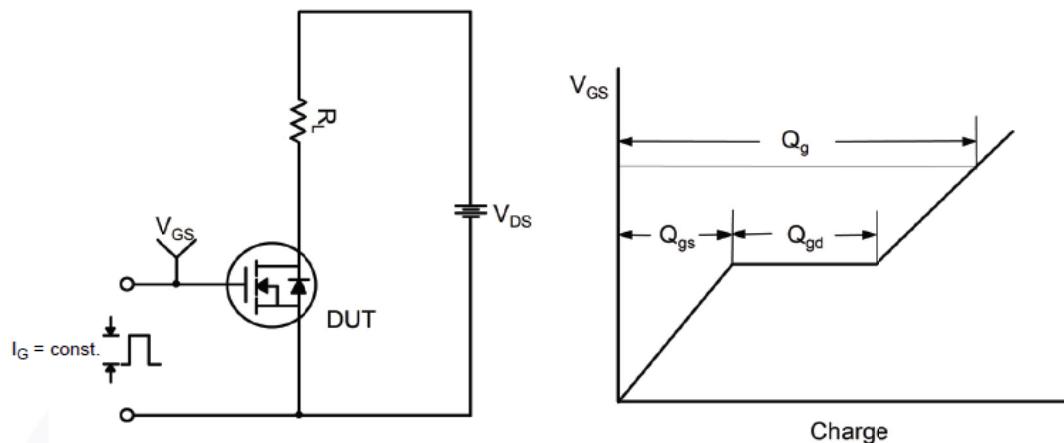
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Fig 13: Max. Transient Thermal Impedance

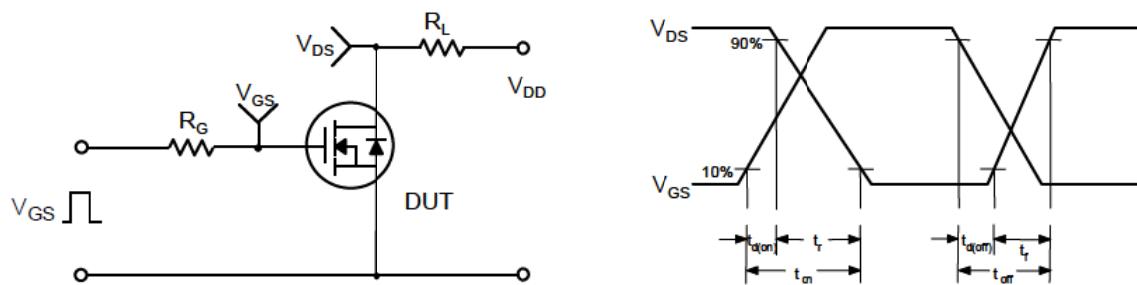


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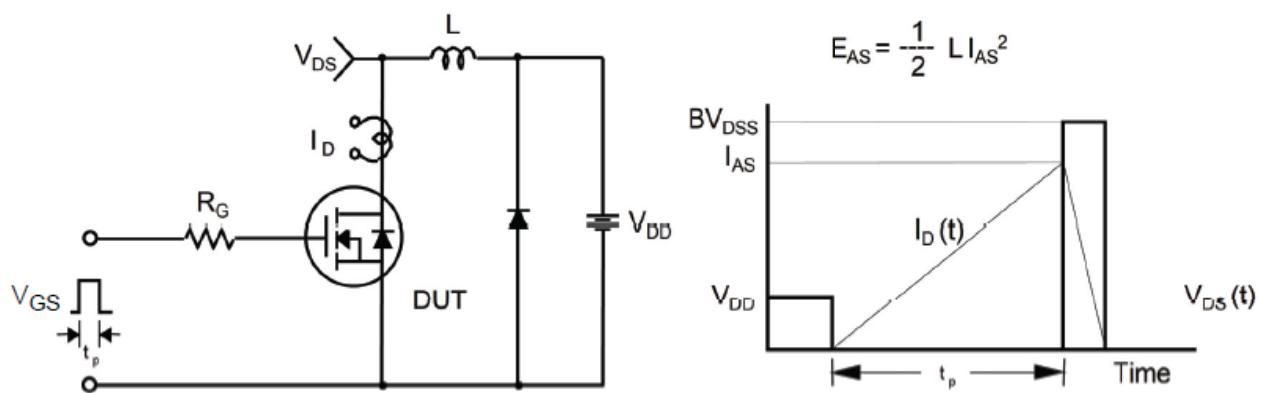
Gate Charge Test Circuit & Waveform



Switching Test Circuit & Waveforms

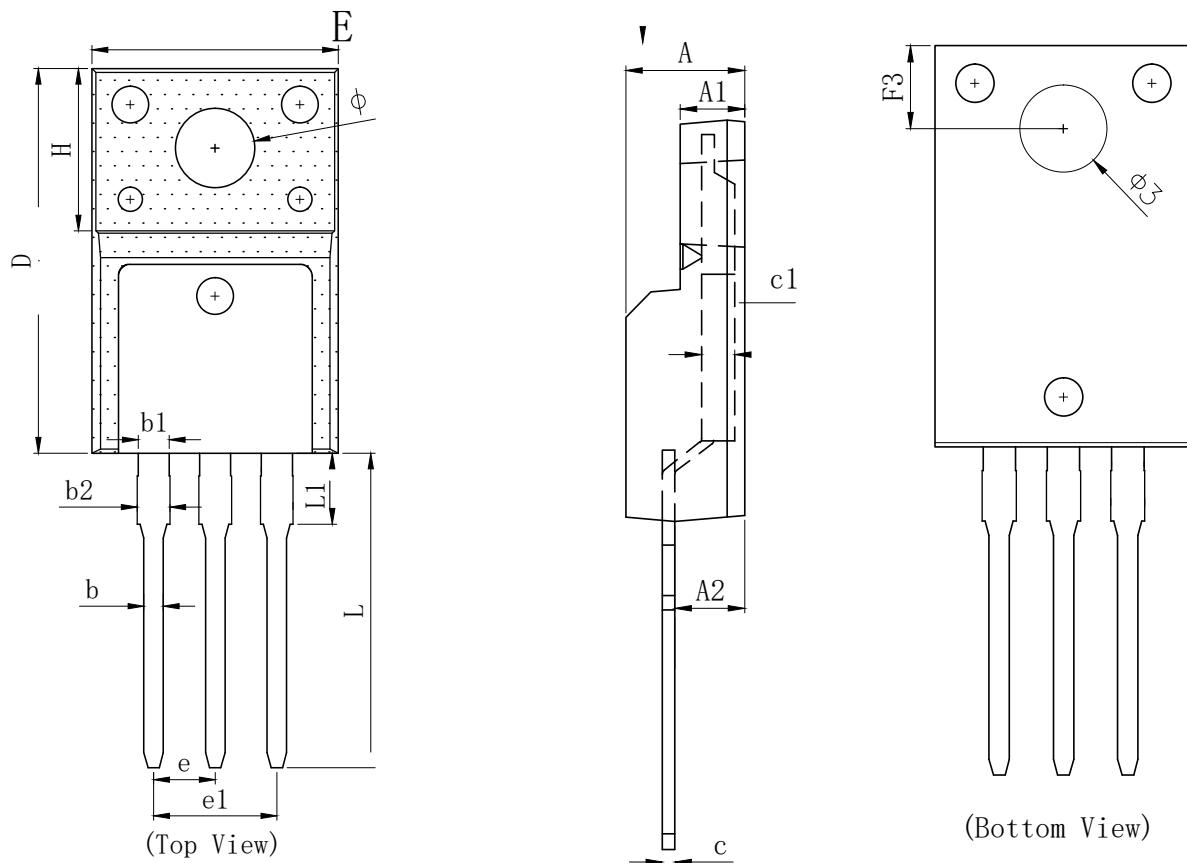


Unclamped Inductive Switching Test Circuit & Waveforms



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Mechanical Dimensions for TO-220F



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	4.500	4.700	4.900
A1	2.340	2.540	2.740
A2	2.560	2.760	2.960
b	0.700	0.800	0.950
b1	1.180	1.280	1.430
b2	1.250	1.350	1.550
c	0.400	0.500	0.650
c1	1.200	1.300	1.350
D	15.570	15.870	16.170
H	6.700 REF		
E	9.960	10.160	10.360
e	2.540 BSC		
e1	5.080 BSC		
L	12.680	12.980	13.280
L1	2.780	2.930	3.080
F3	3.150	3.300	3.450
φ	3.030	3.180	3.450
φ 3	3.150	3.450	3.650